

Identifying Protons Trapped in Hematite Photoanodes Through Structure-Property Analysis

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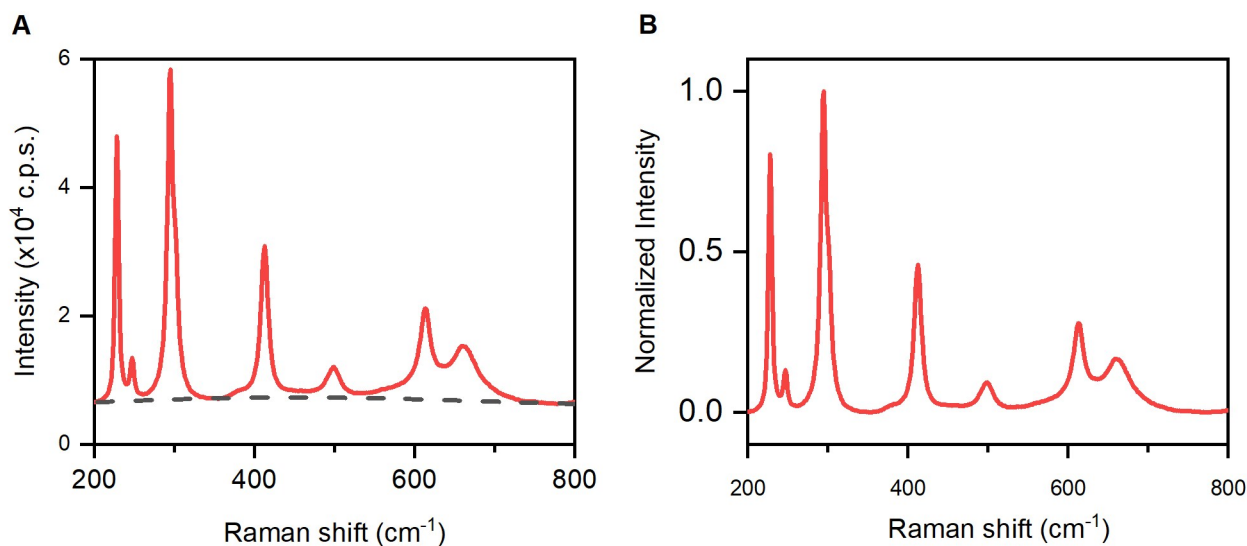


Figure S1. Sample of processing protocol used for Raman spectra showing the sample annealed at 800 °C for 10 min. under humidified N₂ environment. (A) The raw spectrum and baseline to be subtracted. (B) Normalized form of the baseline subtracted data.

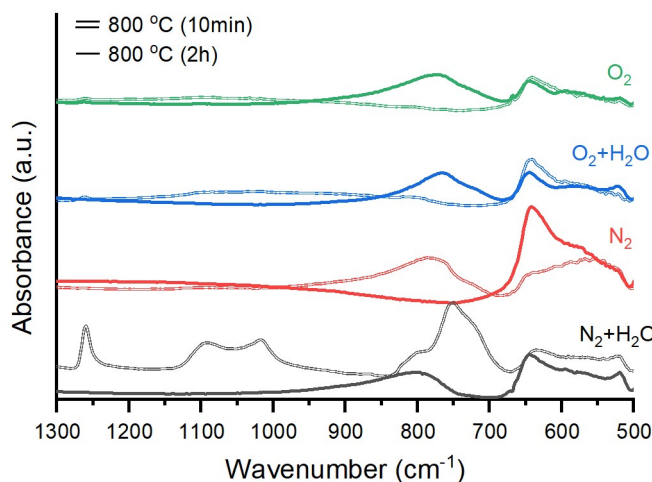


Figure S2. Infrared spectra for hematite thin film samples annealed at 800 °C 10 min and 2h. The sample annealed under humidified N₂ for 10 min is an outlier in all structure-property trends.

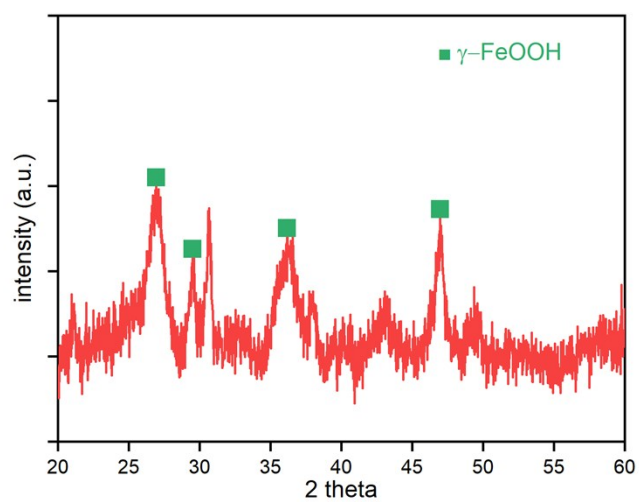


Figure S3. X-ray diffraction pattern obtained on the γ -FeOOH precursor powders.

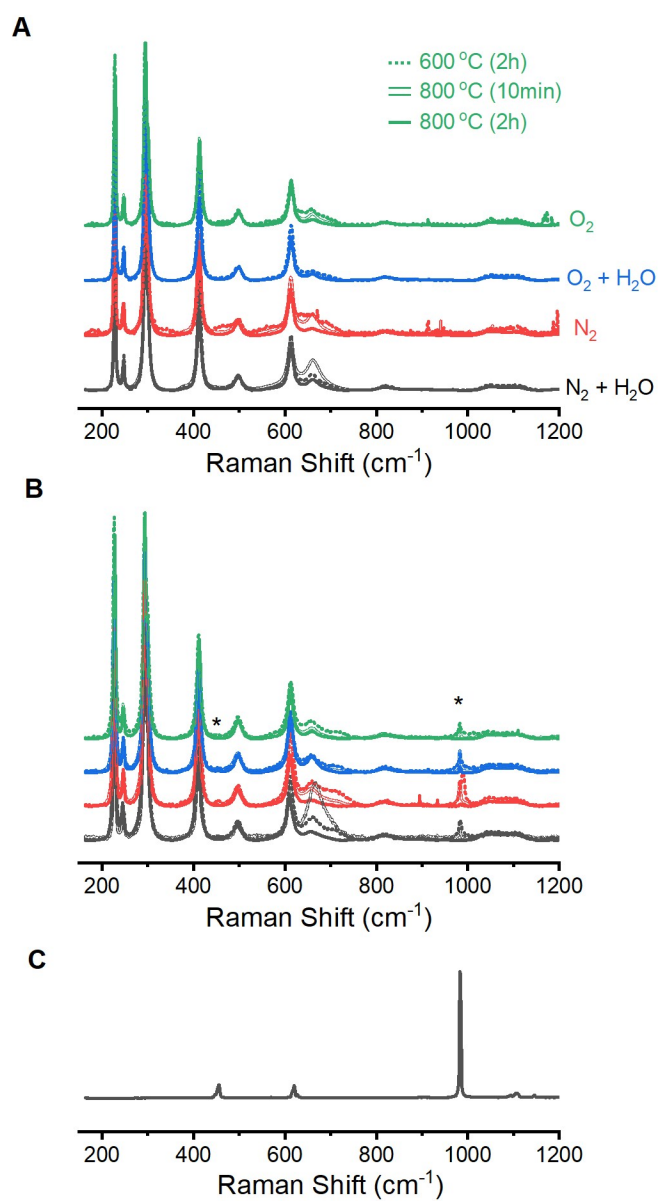


Figure S4. Comparison of Raman spectra for (A) thin film samples and (B) powder samples with (C) K₂SO₄.

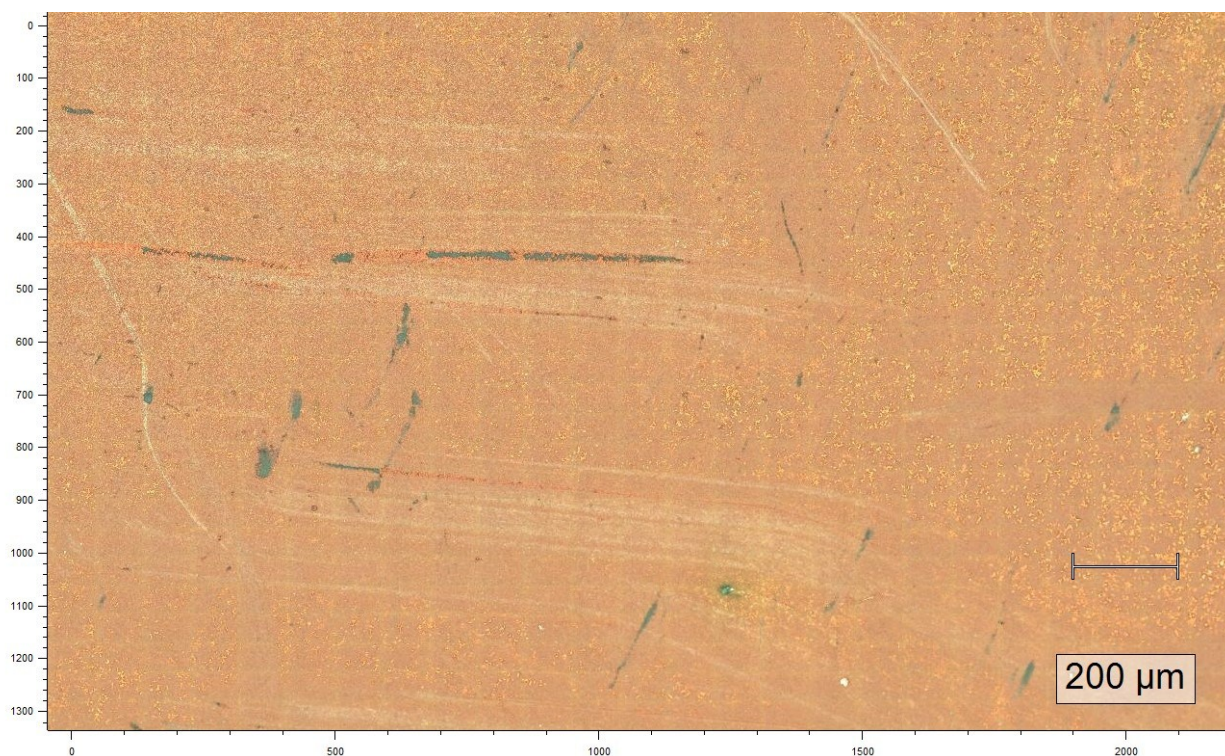


Figure S5. Microscope image of the sample prepared by annealing electrodeposited γ -FeOOH at 800 °C for hours under humidified O₂ atmosphere.

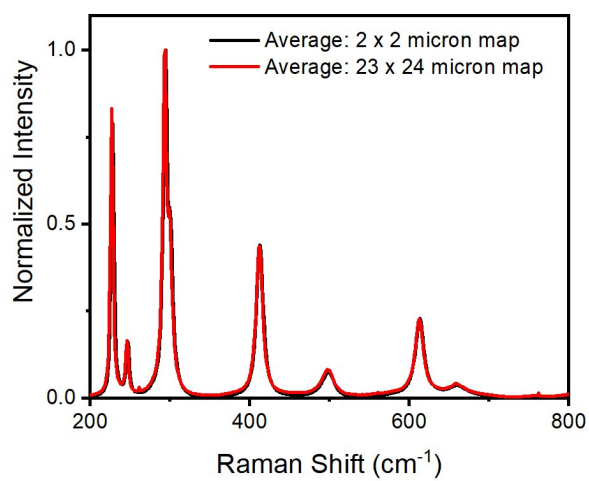


Figure S6. Comparison of the average of all spectra acquired from 2x2 micron squares (27 spectra) and 23 x 24 micron squares (600 spectra).

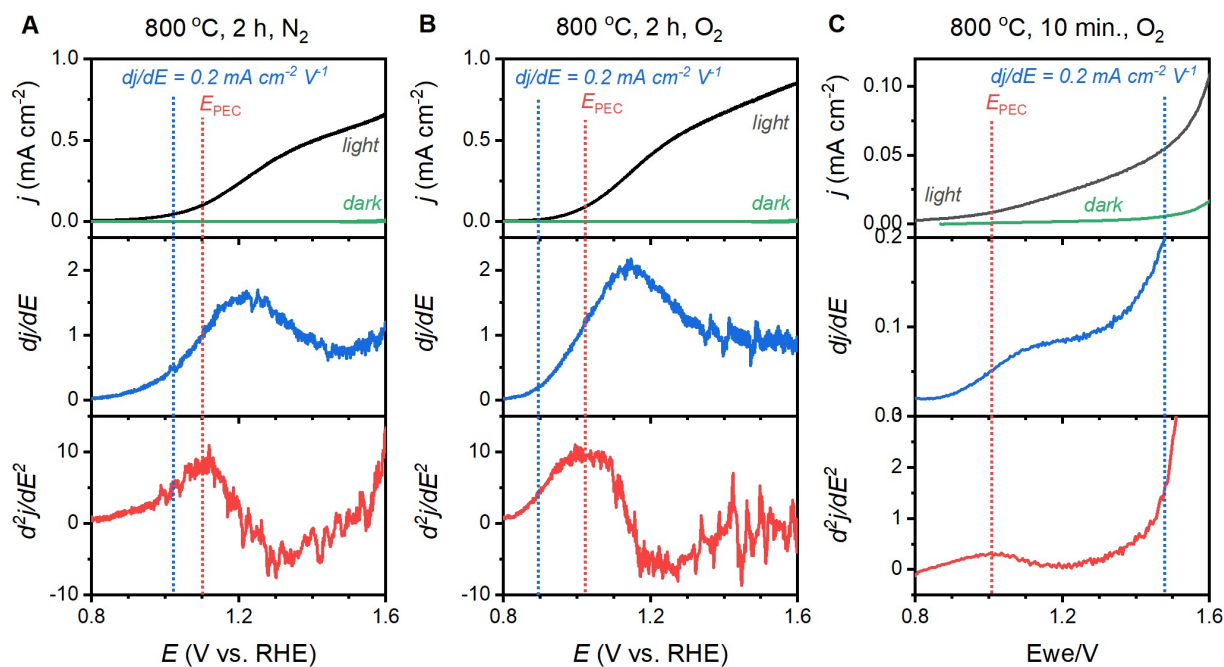


Figure S7. Method for determining photoelectrocatalytic onset. Samples shown are (A) 800 °C for 2 hours under dry N₂ and (B) 800 °C for 2 hours under dry O₂, and (C) 800 °C for 10 min under dry O₂.

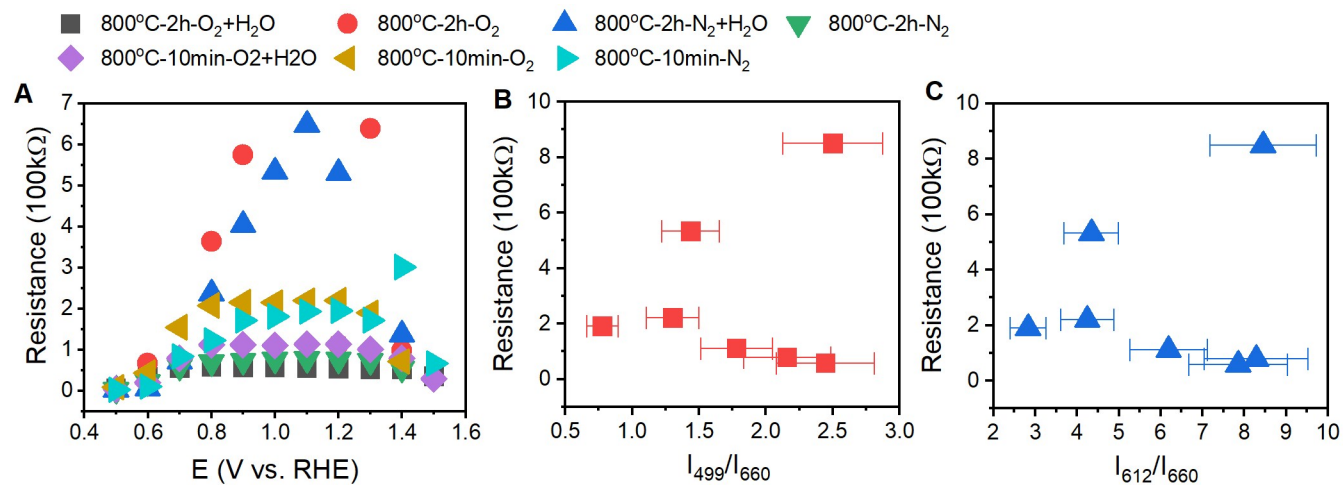


Figure S8. Bulk resistance obtained from fitting EIS data on the α -Fe₂O₃ sample series. (A) Resistance as a function of voltage. Resistance at 1.0 V_{RHE} as a function of Raman intensity ratios (B) I_{499}/I_{660} and (C) I_{612}/I_{660} .

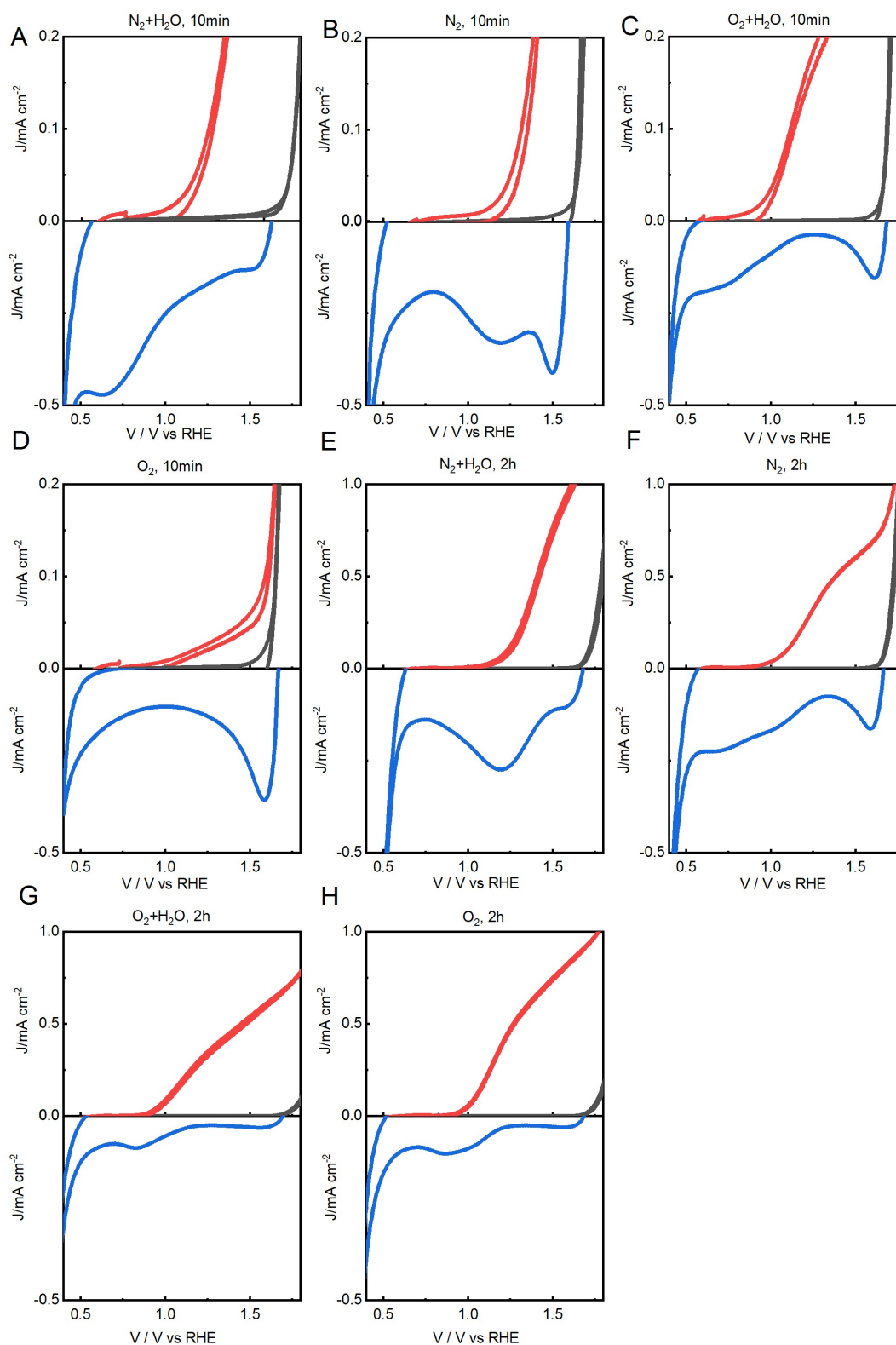


Figure S9. Voltammetric behavior of $\alpha\text{-Fe}_2\text{O}_3$ photoanodes in the dark (black lines) and under illumination (red lines), and 1 V s^{-1} cathodic sweeps following equilibration at an oxidizing voltage while under illumination. Data is shown for samples heated at $800\text{ }^\circ\text{C}$ for 10 minutes in (A) humidified N_2 , (B) dry N_2 , (C) humidified O_2 , (D) dry O_2 , and at $800\text{ }^\circ\text{C}$ for 2 hours in (E) humidified N_2 , (F) dry N_2 , (G) humidified O_2 , (H) dry O_2 .

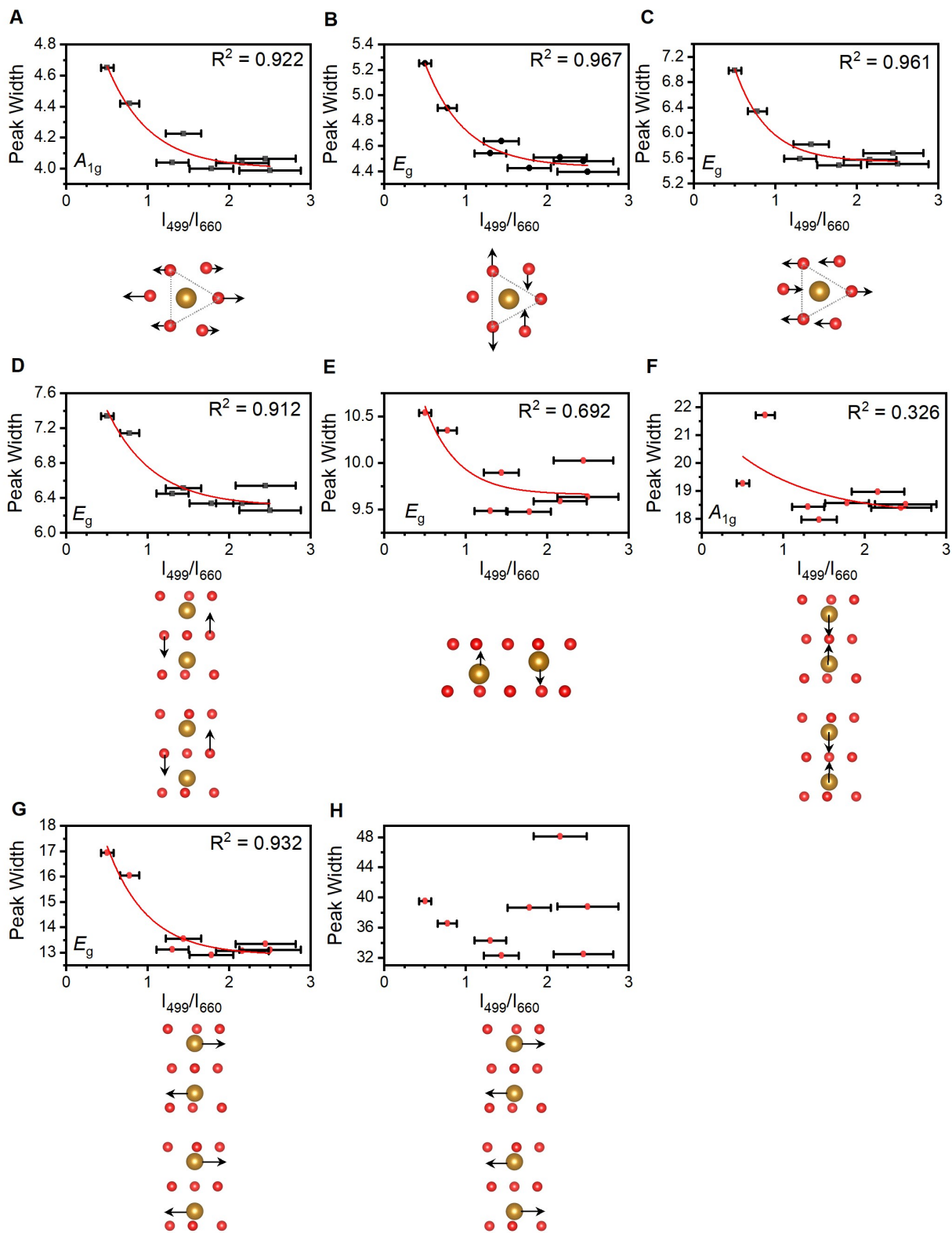


Figure S10. Correlations between peak width and intensity ratio for observed features in the Raman spectra.

Table S1. Location, intensity and width of peak components for the 800 °C α -Fe₂O₃ films.

Sample		A_{lg}	E_g	E_g	E_g	E_g	A_{lg}	E_g	E_u
N ₂ +H ₂ O 10min	Centre	228.02	247.04	294.19	301.02	412.40	497.64	612.93	661.95
	Width	4.65	5.25	6.98	7.34	10.54	19.28	16.94	39.52
	Height	0.80	0.14	0.93	0.34	0.50	0.08	0.26	0.15
N ₂ 10min	Centre	227.38	246.65	293.60	300.33	412.26	497.24	612.98	660.36
	Width	4.42	4.90	6.34	7.14	10.35	21.72	16.04	36.55
	Height	0.81	0.17	0.91	0.40	0.57	0.08	0.29	0.10
O ₂ +H ₂ O 10min	Centre	228.43	247.60	294.56	301.28	413.25	498.10	613.69	662.70
	Width	4.00	4.43	5.49	6.34	9.48	18.57	12.91	38.66
	Height	0.85	0.16	0.93	0.39	0.47	0.07	0.23	0.04
O ₂ 10min	Centre	228.06	247.23	294.27	301.07	413.09	497.79	613.71	661.69
	Width	4.04	4.54	5.59	6.45	9.48	18.44	13.12	34.31
	Height	0.83	0.16	0.95	0.40	0.48	0.07	0.24	0.06
N ₂ +H ₂ O 2h	Centre	227.96	247.06	294.04	300.86	412.65	498.11	613.05	661.73
	Width	4.23	4.64	5.82	6.51	9.90	17.97	13.55	32.29
	Height	0.88	0.14	0.96	0.38	0.44	0.08	0.23	0.05
N ₂ 2h	Centre	227.51	246.75	293.67	300.35	412.28	496.59	612.62	663.06
	Width	4.04	4.51	5.57	6.34	9.59	18.98	13.07	48.11
	Height	0.81	0.17	0.92	0.40	0.51	0.06	0.25	0.03
O ₂ +H ₂ O 2h	Centre	228.26	247.39	294.32	301.09	412.93	498.15	613.29	660.97
	Width	4.06	4.48	5.68	6.54	10.03	18.40	13.34	32.48
	Height	0.85	0.16	0.95	0.38	0.44	0.07	0.23	0.03
O ₂ 2h	Centre	228.44	247.60	294.54	301.31	413.18	498.22	613.52	662.74
	Width	3.99	4.40	5.51	6.26	9.64	18.53	13.11	38.80
	Height	0.85	0.15	0.94	0.39	0.46	0.07	0.23	0.03

Table S2. Carrier concentration values compared to photocurrent densities for α -Fe₂O₃ films prepared at 600 and 800 °C.

Sample	$\log(N_d/\text{cm}^{-3})$	$j_{L,231}(\text{mA}\cdot\text{cm}^{-2})$
N ₂ +H ₂ O, 600 °C	20.53	0.0078
N ₂ , 600 °C	21.05	0.0045
O ₂ +H ₂ O, 600 °C	20.41	0.010
O ₂ , 600 °C	20.34	0.0026
N ₂ +H ₂ O, 10min, 800 °C	22.30	0.08
N ₂ , 10min, 800 °C	22.18	0.04
O ₂ +H ₂ O, 10min, 800 °C	20.56	0.18
O ₂ , 10min, 800 °C	20.32	0.02
N ₂ +H ₂ O, 2h, 800 °C	21.69	0.16
N ₂ , 2h, 800 °C	21.06	0.36
O ₂ +H ₂ O, 2h, 800 °C	20.50	0.41
O ₂ , 2h, 800 °C	20.48	0.48